FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

	Sheet I of I		
ATTY. DOCKET NO.	SERIAL NO. 09/8/8584		
P107424-00024	New Application		
APPLICANT	EXAMINERO		
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FILING DATE	GROUP GROUP		
March 28, 2001	178 =		

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANS YES	NO
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Sheet 1 of ATTY. DOCKET NO. SERIAL NO. **FORM PTO-1449** U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **OKA-0024** 09/818,584 APPLICANT LIST OF REFERENCES CITED BY APPLICATE **FUKUZAWA** JAN 0 8 2002 FILING DATE (Use several sheets if necessary) 265T 175C March 28, 2001 U.S. PATEN DOCUMENTS **EXAMINER** SUB-**FILING DOCUMENT** INITIAL DATE **CLASS CLASS** DATE NAME NO. AA RECEIVED AB AC AD echnology Center 2600 ΑE **FOREIGN PATENT DOCUMENTS** DOCUMENT SUB-**TRANSLATION** NO. DATE COUNTRY **CLASS** YES NO PART. CLASS AG 10/14/92 0 508 478 A1 Europe Х AΗ ΑI ΑJ ΑK ΑL OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) RECEIVED TO 1700 AM ΑN AO **EXAMINER** Mu DATE CONSIDERED

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*EXAMINER: